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Two-Dimensional van der Waals Materials with Aligned In-Plane Polarization and Large Piezoelectric Effect for Self-Powered Piezoelectric Sensors

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Supporting Information Placeholder

ABSTRACT: Piezoelectric two-dimensional (2D) van der Waals (vdWs) materials are highly desirable for applications in miniaturized and flexible/wearable devices. However, the reverse-polarization between adjacent layers in current 2D layered materials results in decreasing their in-plane piezoelectric coefficients with layer number, which limits their practical applications. Here, we report a class of 2D layered materials with an identical orientation of in-plane polarization. Their piezoelectric coefficients (e_{22}) increase with layer number, thereby allowing for the fabrication of flexible piezotronic devices with large piezoelectric responsivity and excellent mechanical durability. The piezoelectric outputs can reach up to 0.363 V for a 7-layer α - In_2Se_3 device, with a current responsivity of 598.1 pA for 1% strain, which is one order of magnitude higher than the values of the reported 2D piezoelectrics. The self-powered piezoelectric sensors made of these newly developed 2D layered materials have been successfully used for real-time health monitoring, proving their suitability for the fabrication of flexible piezotronic devices due to their large piezoelectric responses and excellent mechanical durability.

KEYWORDS: indium selenide, asymmetric structure, stacking sequence, robust piezoelectricity, piezo-responsivity, sensors

INTRODUCTION

Piezoelectric materials with intrinsic non-centrosymmetric crystal structures allow for inter-conversion between electrical energy and mechanical energy.¹ They are widely used for actuators, energy harvesters, functional sensors, and other applications.²⁻⁴ Since the first demonstration of piezoelectricity in quartz crystals in 1880 by the brothers Pierre Curie and Jacques Curie, a series of piezoelectric materials were developed, including piezoelectric crystals (such as quartz, GaN, BaTiO₃, etc.) and piezoelectric ceramics (such as lead zirconate titanate (PZT) system). Among these piezoelectric materials, piezoelectric ceramics such as PZT and barium titanate (BTO) are the most widely used due to their excellent electromechanical conversion.⁵

For some important applications, piezoelectric materials are required to be thin, flexible, chemically stable and also bio-compatible such as artificial

intelligent interface electronics, flexible/wearable devices, and bio-implantable electronics.⁴ These requirements are difficult to be achieved using the conventional piezoelectric ceramics, because they have no mechanical flexibility and lack chemical stability in bio-environment; and some of them contain toxic components.⁶ These problems may be solved by the use of strong, flexible, ultrathin piezoelectrics of 2D layered materials. Since the pioneering studies of piezoelectricity in monolayer MoS₂ by the research groups of Wang and Zhang in 2014, researchers focused on improving the piezoelectric efficiency of the 2D materials.^{7,8} So far, the reported piezoelectric vdWs layered semiconductors include hexagonal boron nitride (*h*-BN), transition metal dichalcogenides (TMDs), layer-phase group III monochalcogenides (i.e. GaS, GaSe, and InSe), and group IV monochalcogenides (MX, M=Sn or Ge, X=Se or S).⁹⁻¹³ These layered materials have an inversion symmetry in their bulk structures, whereas they lose the inversion symmetry as their thickness is thinned down to monolayer or a few odd-layers.^{7,8} Furthermore, their in-plane piezoelectricity is significantly decreased with the increase of atomic layer number, because the reversed polarization directions between adjacent layers result in the cancellation of polarization. Therefore, the monolayer structure has the largest in-plane piezoelectric coefficient

for those vdWs layered materials, even larger than some conventional bulk piezoelectric crystals, such as gallium nitride and aluminum nitride.⁹

However, there are two bottleneck problems for applying atomically thin monolayer piezoelectrics in practical device applications: (i) Their small piezoelectric outputs cannot produce high responsivity due to its exceedingly small effective volume. For example, the piezoelectric current and voltage outputs are only about dozens of pA and mV for monolayer MoS₂, respectively.⁷ (ii) The poor mechanical stability for the monolayer cannot sustain long-term durability.¹⁴⁻¹⁶ To address above problems, a turbostratic stacking approach was demonstrated to manipulate the polarization in artificial bilayer or multilayers for inducing or enhancing the degree of structural non-centrosymmetry.¹⁴ However, this complex process and the uncontrollable performance of the artificial multilayer hinder its potential for broad practical applications. Herein, a new class of 2D piezoelectric materials is proposed that exhibit the same polarization orientation between adjacent monolayers, which can simultaneously offer large piezoelectric output signals and long-term durability by use of multilayer structures.

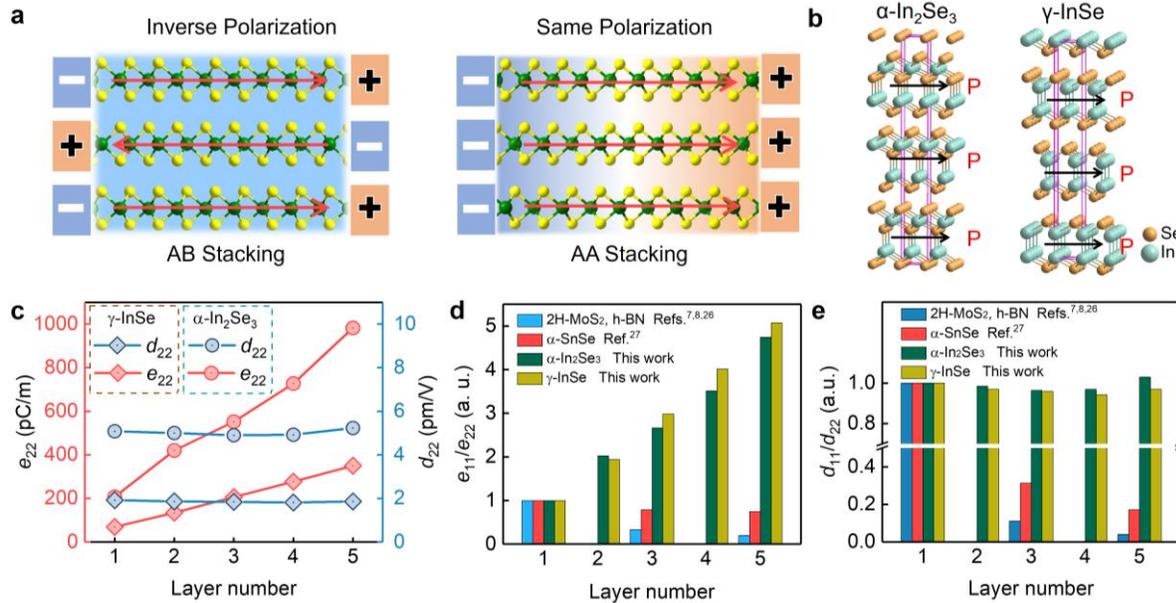


Figure 1. Piezoelectricity in vdWs layered materials. (a) The distribution of in-plane polarization under tensile strain in vdWs layered materials. The polarized direction (red arrows) are inverse or same in AB or AA stacking case. (b) Piezoelectric with same polarization direction (black arrows) in a unit cell of α -In₂Se₃ (left) and γ -InSe (right). (c) Layer number dependence of piezoelectric stress coefficients (e_{22}) and piezoelectric strain coefficients (d_{22}) for few-layer α -In₂Se₃ and γ -InSe. (d, e) Comparison of piezoelectric coefficients dependence on layer number with other typical two-dimensional materials. (The theoretical data (e_{11}/e_{22} and d_{11}/d_{22}) for *h*-BN, 2H-MoS₂ and SnSe are adopted from refs.^{7,8,26,27}).

RESULTS AND DISCUSSION

Stacking sequence governed piezoelectricity in 2D vdWs materials. Firstly, we discuss the relationship between crystal structure and piezoelectricity for these materials. The vdWs layered semiconductors have rich polytype phases with diverse physical properties in different stacking configurations and possess different crystal symmetries.^{17,18} For example, semiconducting MoS₂, as a most studied vdWs layered material, can be in either 2H-type or 3R-type structures when they are in AB or AA stacking configurations, corresponding to centrosymmetric and non-centrosymmetric crystal structures, respectively.¹⁹ The 2H-MoS₂ with the AB stacking sequence is the most thermodynamically stable phase, which can be produced with a large yield.²⁰ For the 2H-MoS₂ with the AB stacking, the strain induced dipoles have reverse directions in adjacent layers, and the piezoelectric contribution of each layer is neutralized by its neighboring layer. As a result, the overall piezoelectric effect is only significant for a few odd numbers of monolayers (left in Figure 1a). In contrast, the 3R-MoS₂ layers with the AA stacking have identical directions of strain induced dipoles in adjacent layers, thus resulting in strong piezoelectric effect in multilayer structures (right in Figure 1a). However, the thermodynamic instability and uncontrollability of synthesis make 3R-MoS₂ an unsuitable candidate for the 2D piezoelectric material.¹⁷ Indium selenides, on the other hand, belong to a complex family of polytypes with different stoichiometric ratios and phases, such as layered In₂Se₃ (α and β phase) and InSe (β , γ and ϵ phase). The indium selenides in multilayers or bulk crystal are thermodynamically stable in ambient conditions, and can be produced in a pure phase by a suitable procedure, such as chemical vapor deposition (CVD), vapor transport, Bridgeman method and so on.²¹ Both α -In₂Se₃ and γ -InSe have non-centrosymmetric crystal structures, corresponding to $R\bar{3}m$ (No.160) space group. Recently, studies of ferroelectricity in the α -In₂Se₃ proved that it was a promising new vdWs layered material for potential piezoelectric applications.²²⁻²⁵

In the structures of α -In₂Se₃ and γ -InSe (Figure 1b), there are three layers stacked vertically via vdWs interaction with AA sequence in a unit cell (indicated by pink frame in Figure 1b). This stable stacking configuration leads to the same in-plane polarized directions in all the layers under a uniaxial strain (more details in Supporting Information). Hence, their multilayer structures should always exhibit piezoelectric effects no matter the existence of odd- or even-layer number, and should have much higher polarized charge densities than those of the currently reported 2D piezoelectric materials that have inversion centers in their even-layer flakes.

To verify these assumptions, the piezoelectric coefficients of both α -In₂Se₃ and γ -InSe as a function of layer number were obtained through the first-principles simulations using density functional theory (DFT). The obtained planar elastic stiffness coefficients C_{11} and C_{12} , relaxed-ion piezoelectric stress coefficients e_{22} , and relaxed-ion strain coefficients d_{22} , are listed in Tables S1 and S2. The value of piezoelectric stress coefficient e_{22} , is proportional to layer numbers, varying from 207 pC/m for 1L to 982 pC/m for 5L (Figure 1c). Thus, the piezoelectric strain coefficients d_{22} remains at a value of 5.022 ± 0.21 pm/V in α -In₂Se₃ when the layer number is increased from one layer (1L) to five layer (5L). As for γ -InSe, its e_{22} value is increased from 69 to 350 pC/m (for 1L to 5L), and its d_{22} remains a value of 1.86 ± 0.06 pm/V. Clearly, the piezoelectricity in both α -In₂Se₃ and γ -InSe shows a strong dependence on layer number (Figure 1d and e), which is totally different from those of the currently reported piezoelectric layered materials, such as 2H-MoS₂, *h*-BN and α -SnSe.^{7,8,26,27} The calculated piezoelectric coefficients e_{11} and d_{11} of 2H-MoS₂, *h*-BN and α -SnSe are decreased with odd layers from 1L, 3L, to 5L, and disappear with even layers of 2L and 4L. Whereas the d_{22} values of multilayer α -In₂Se₃ and γ -InSe remain a constant value despite of its odd- or even-layer number, and their e_{22} value is increased as layer number is increased from 1L to 5L (Figure 1d and 1e).

Characterization and layer number dependent piezoelectricity in α -In₂Se₃. The piezoelectric properties of 2D α -In₂Se₃ were experimentally investigated. The monolayer and few-layer α -In₂Se₃ flakes (up to 7L) were grown using a CVD method (Figure S6, Supporting Information). High-resolution transmission electron microscope, selected area electron diffraction and atomic force microscopy were utilized to confirm the high crystalline quality and the thickness of as-prepared α -In₂Se₃ (Figure S7 and S8, Supporting Information). Three Raman peaks at 104, 183 and 202 cm⁻¹ were attributed to A₁(LO+TO), A₁(LO) and A₁(LO) vibration modes, respectively (Figure 2a), indicating the lack of an inversion symmetry in α -In₂Se₃ with $R\bar{3}m$ space group.²⁴ Further, second harmonics generation (SHG) was utilized to determine the symmetry variations in a few-layer α -In₂Se₃.²⁸ To demonstrate the retaining of broken inversion symmetry for the α -In₂Se₃ with both odd- and even-layers, the SHG intensity mappings were taken in both parallel and perpendicular polarization configurations from the samples with different layer numbers (e.g., 3L and 5L). The SHG intensity for the 5L α -In₂Se₃ flake was higher than that of 3L flake (Figure S10, Supporting Information). This indicates that there is indeed no inversion center for the even-layer α -In₂Se₃, and each layer exhibits the same In-Se bond direction in the adjacent layers.²⁹ Moreover, the SHG intensity mapping shows a uniform intensity distribution over the

entire area, indicating a high crystalline quality of the as-grown α -In₂Se₃ flake (Figure 2b). Furthermore, the angle dependence of SHG intensity taken in parallel polarization configurations shows a six-fold rotational symmetry ($I = I_0 \cos^2(3\theta)$), which also validates that the

α -In₂Se₃ belongs to $R3m$ space group with a three-fold rotational symmetry (Figure 2c and Figure S10d in Supporting Information).¹⁷ This broken center symmetry in rational thickness is of the essence for the unusual piezoelectricity in multilayer α -In₂Se₃.²⁴

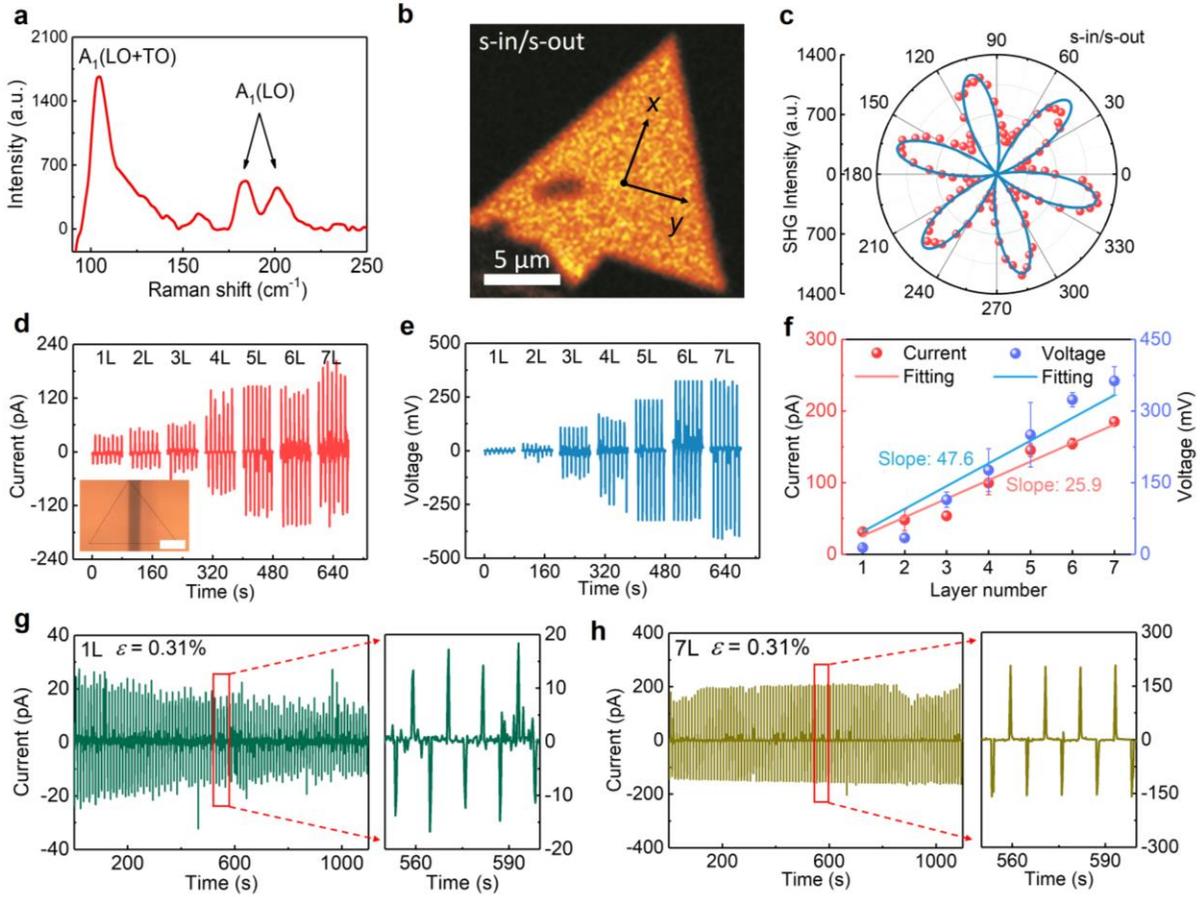


Figure 2. Structure and piezoelectricity of as-synthesized α -In₂Se₃. (a) Raman spectra of α -In₂Se₃ transferred onto SiO₂/Si substrate. (b) SHG mapping of a single α -In₂Se₃ crystal on mica. (c) The polarization angle θ dependent SHG intensity. It exhibits a clear six-fold rotational symmetry ($I = I_0 \cos^2(3\theta)$). (d) Current responses in α -In₂Se₃ devices with different layers (from 1L to 7L) under periodic strain. Inset: a typical optical image of α -In₂Se₃ based device. Scale bar: 10 μ m. (e) Voltage responses in α -In₂Se₃ devices with different layers (from 1L to 7L) under periodic strain. (f) The piezoelectric current and voltage outputs as a function of α -In₂Se₃ layer number. (g, h) Stability of α -In₂Se₃ piezoelectric device. Current response from cycling test a 1L α -In₂Se₃ device (g) and a 7L α -In₂Se₃ device (h). The piezoelectric device based on 7L α -In₂Se₃ shows better durability than that of 1L α -In₂Se₃. The current and voltage outputs shown in Figure 2d-h were obtained under a fixed strain of 0.31% with a strain velocity of 10 mm/s.

To measure the piezoelectric properties, two-terminal devices with a channel length of 5 μ m and a width of 60 μ m were fabricated using α -In₂Se₃ flakes with different thicknesses (from 1L to 7L) (Figure S11, Supporting Information). Considering the degradation of indium selenide flakes in ambient conditions, all devices were packed by polydimethylsiloxane (PDMS) thin film (see Method in Supporting Information).³⁰ The piezoelectric responses of the devices (including current and voltage outputs) were systematically studied (the detailed data is

provided in Supporting Information). The intrinsic piezoelectricity of α -In₂Se₃ flakes was confirmed by monolayer device.^{7,31} More importantly, we investigated the layer number influence on the piezoelectric properties of α -In₂Se₃ flakes. Here, all the output results were obtained with a fixed applied strain (0.31%) and strain velocity (10 mm/s), and a device size of 5 \times 60 μ m². The recorded output peak currents and voltages are increased from 31.5 \pm 3.0 to 185.4 \pm 6.0 pA and from 14.0 \pm 3.0 to 363.3 \pm 30.0 mV with the increase of layer number from

1L to 7L (Figure 2d and 2e). Figure 2f shows the output performance of the α -In₂Se₃ device as a function of layer number (from 1L to 7L). The output currents and voltages are increased almost linearly with the increase of layer number, which originates from the addition of contact area with a constant polarized charge density. The relationship between the output peak current (I_p) and layer number (n) can be represented as: $I_p \propto n$ (the detailed analysis is provided in Supporting Information). This makes it more sensitive to strain change than other 2D layered piezoelectric materials reported in the literature (see Table S4, Supporting Information). For example, the current responsivity of 7L α -In₂Se₃ can reach up to around 598.1 \pm 19.4 pA for each 1% strain, which is about one order of magnitude higher than that of monolayer 2H-MoS₂ (55.1 \pm 12.3 pA).⁷

Moreover, the mechanical durability and stability of devices during strain cycling were evaluated by testing 1L and 7L α -In₂Se₃ devices (Figure 2g and 2h). After cycling over 1000 seconds, the output peak current of 1L α -In₂Se₃ device was decreased from 21.8 to 12.3 pA, which is \sim 56.4 % of the initial value, whereas the 7L α -In₂Se₃ device remained a peak current of 185.4 \pm 18.5 pA. In addition, the output peak voltage of the 7L α -In₂Se₃ device remains a constant without apparent decreases (Figure S19, Supporting Information). The good mechanical stability and large piezoelectric response endow the multilayer structure to be suitable for practical applications in flexible/wearable electronics and implant devices.

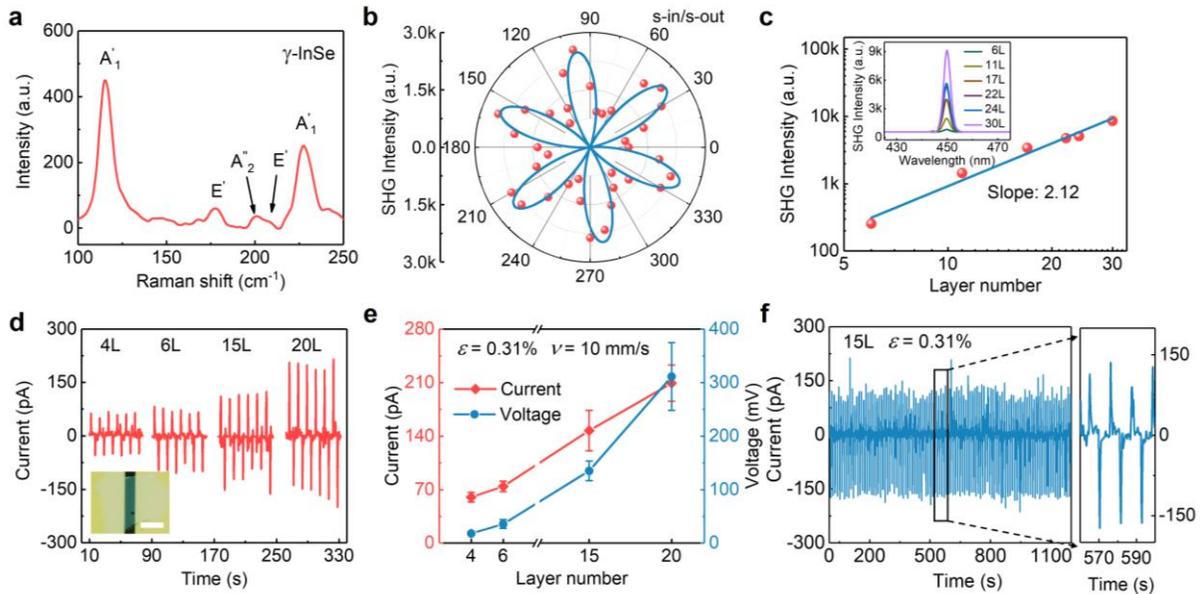


Figure 3. Structure and piezoelectricity of exfoliated γ -InSe. (a) Raman spectra of γ -InSe. (b) The polarization angle (θ) dependent SHG intensity of γ -InSe. It exhibits a clear six-fold rotational symmetry ($I = I_0 \cos^2(3\theta)$). (c) SHG Intensity as a function of γ -InSe layer number. Inset: the SHG intensity of γ -InSe with different layer numbers. (d) Current responses in γ -InSe devices with different layers under periodic strain of 0.31% with a strain velocity of 10 mm/s. Inset: a typical optical image of γ -InSe based device. Scale bar: 10 μ m. (e) The piezoelectric current and voltage outputs as a function of γ -InSe layer number. (f) Current response from cyclic testing a 15L γ -InSe device under a strain of 0.31% and a strain velocity of 10 mm/s.

Characterization and layer number dependent piezoelectricity in γ -InSe. In addition, we studied the structures and piezoelectricity of the exfoliated γ -InSe nanosheets. The γ -InSe has the same atomic arrangement in a monolayer with those of β - and ϵ -type, but has three layers stacked in a unit cell with the AA stacking sequence, which possesses a non-centrosymmetric crystal structure.³²⁻³⁴ Raman spectroscopy was used to identify the structure of γ -InSe (Figure 3a). Five Raman peaks at

116 cm^{-1} , 177 cm^{-1} , 200 cm^{-1} , 208 cm^{-1} and 227 cm^{-1} are attributed to A_1' , E' , A_2'' , E'' and A_1' Raman modes of γ -InSe, respectively.³⁴ Moreover, HRTEM and SAED pattern further confirmed the crystal structure and crystalline quality of γ -InSe flake (Figure S20, Supporting Information). The angle dependence of SHG intensity indicates a three-fold rotational symmetry of γ -InSe, which belongs to $R3m$ space group (Figure 3b). Furthermore, the SHG intensity increases with the

thickness of γ -InSe, which can be well interpreted by using the equation $I \propto d^2$ (d is the layer thickness) (Figure 3c). This indicates that γ -InSe maintains a non-centrosymmetric structure for both odd- and even-layers.³⁵ Under the uniaxial strain, the apparent polarization is enhanced with the increase of layer numbers due to their same polarization orientations in all layers.

To further explore the piezoelectricity of multilayer γ -InSe, its piezoelectric outputs were measured along the armchair direction, and then normalized with the active area of device. The piezoelectric responses were observed in both odd- and even-layer γ -InSe devices (Figure 3d and Figure S21, Supporting Information). The current output

peaks are increased from 60.0 ± 6.4 for 4L to 209.0 ± 23.6 pA for 20L, and the voltage output peaks are increased from 17.9 ± 3.2 for 4L to 311.4 ± 63.4 mV for 20L (Figure 3e). By increasing the applied strain from 0.21% to 0.62%, the current and voltage responses for the 4L γ -InSe device were increased from 19.0 ± 5.3 to 61.5 ± 3.5 pA and from 30.8 ± 5.2 to 68.2 ± 9.2 mV, respectively (Figure S22, Supporting Information). The mechanical durability and stability of a 15L γ -InSe device were further estimated using the cycling test for over 1000 seconds (Figure 3f and Figure S23, Supporting Information). There are no apparent deterioration of the current and voltage responses of this multilayer γ -InSe, indicating a promising potential for the flexible devices.

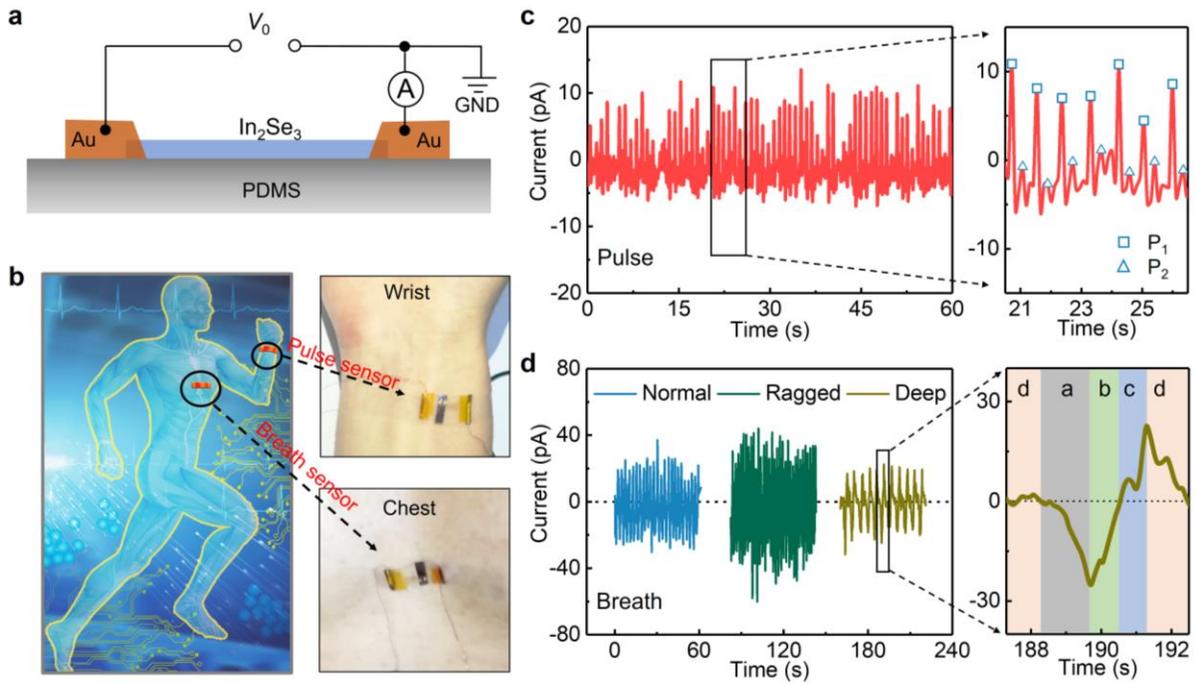


Figure 4. Self-powered piezoelectric sensors. (a) The schematic of self-powered piezotronic sensor based on a multilayer α - In_2Se_3 flake. (b) Real-time monitoring of physiological signals (left). The piezotronic sensor based on few-layer In_2Se_3 are attached on skin at wrist (top right) and chest (bottom right) for monitoring arterial pulse and breath, respectively. (c) Real-time monitoring of arterial pulse signals. Left: the measured transient arterial pulse signals. Right: the signals zoomed in black rectangle shown in left (P_1 : square symbols, P_2 : triangle symbols). (d) Real-time monitoring of breath signals. Left: output current responses obtained when measuring breath signals with different physical states, as indicated. Right: the time synchronization of current tracks to deep breath. (a: breath in, b: breath gap, c: breath out, d: breath gap).

Performance of the piezoelectric sensors for healthcare monitoring. The large piezoelectric responses and long-term mechanical durability of multilayer α - In_2Se_3 and γ -InSe allow us to develop sensitive and efficient flexible piezotronic sensors, such as pulse and breath monitoring.³⁶ Here, we demonstrate a self-powered sensor (without any external bias) using a multilayer α - In_2Se_3 flake on the soft substrate of PDMS

thin films (Figure 4a). The as-made flexible and wearable sensors were utilized to perform real-time monitoring of human's pulse and breath by attaching the devices onto the wrist and chest (Figure 4b). By using our piezoelectric sensor, the pulse rate was measured to be about 72 bpm, which is consistent with the results from a commercial pulse sensor (the data were obtained from an app in a smart phone with a heart rate sensor, see Figure 4c and

Figure S24, Supporting Information). As shown in right of Figure 4c, two clear peaks are distinguishable in a pulse, which are caused by superposition of the incoming blood wave ejected by the left ventricular (P_1) and the reflected wave from the lower body (P_2).²⁹ Apparently, the self-powered piezoelectric multilayer device exhibits a high sensitivity and good reliability. In contrast, signals obtained from a monolayer α - In_2Se_3 device are too weak to be distinguished from the background noise (Figure S25, Supporting Information). Moreover, the multilayer α - In_2Se_3 device also shows a good performance in monitoring breath (Figure 4d). Three different breath states can be accurately recorded. With regard to ragged breathing (e.g., the breath frequency is much higher and the chest undulation is more significant), the device produces a higher frequency and larger current outputs (as shown in Figure 4d). Whereas if using this device to monitor the deep breath, both the frequency and output current signals are much lower (dark yellow in Figure 4d). For all the cases, the current signals are synchronous to the breathing sequence, indicating that the piezoelectric sensor has a good time-resolution.

Expansion of the 2D vdWs piezoelectric materials family. Based on the above results obtained in this work, there should be a lot of other 2D vdWs piezoelectric materials, which should show similar piezoelectric properties with α - In_2Se_3 and γ - InSe . To verify this, we investigated many 2D vdWs layered materials reported in literature and studied the crystal structure collected in the database of the Crystallographic Open Database (COD).³⁷ We found that some vdWs layered materials with the non-centrosymmetric structures, such as ϵ - InSe/GaSe ($P-6m2$), γ - GaSe ($R3m$) and α - GeTe/SnTe ($R3m$), may belong to such class of piezoelectric materials.^{32,38-41} The absence of inversion center in multilayer form, together with high mechanical durability, make them ideal 2D piezoelectric materials for practical application.⁴²

CONCLUSIONS

In summary, we have discovered the large piezoelectric effects in a new class of 2D vdWs materials, which are ideal for flexible piezotronic/piezo-phototronic devices with both high sensitivity and good durability. The family of such vdWs layered materials has been extended. Furthermore, in addition to their correlation with piezotronics and semiconducting properties, these 2D vdWs layered materials not only expand the family of piezoelectric materials and enrich the science of 2D materials, but also enable innovative applications in flexible/wearable devices and self-powered sensors.

ASSOCIATED CONTENT

The Supporting Information is available free of charge on

the ACS Publications website.

Experimental section and method, Supporting text, Figure S1-S25 and References S1-S12. (PDF)

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Notes

The authors declare no competing financial interest.

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